



SN 09/723,010

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant:	Nguyen N. Ngo et al.	Examiner:	David Ton
Serial No.:	09/723,010	Group Art Unit:	2133
Filed:	November 27, 2000	Docket:	884.318US1
Title:	IMPROVED MEMORY FAULT ISOLATION APPARATUS AND METHODS		
Assignee:	Intel Corporation		

Mail Stop Issue Fee
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

AMENDMENT UNDER 37 C.F.R. § 1.312(a)

In response to the Notice of Allowance and Notice of Allowability mailed April 11, 2003,
please amend the specification and claims as follows: